

Notice of References Cited

Application/Control No.

10/643,166

Applicant(s)/Patent Under
Reexamination
KIM ET AL.

Examiner

LINH T. NGUYEN

Art Unit

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Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0123343	07-2003	Schep et al.	369/44.26
*	B	US-2003/0012123	01-2003	Miyamoto et al.	369/275.4
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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